

Oxide perovskite crystals type $ABCO_4$: application and growth

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In the last year great interest appears to YBCO thin films preparation on different substrate materials. Preparation of epitaxial film is a very difficult problem. There are many requirements to substrate materials that must be fulfilled. Main problems are lattice mismatch (misfit) and similarity of structure. From paper [1] it follows that difference in interatomic distances and angles of substrate and film is more important problem than similarity of structure. In this work we present interatomic distances and angle relations between substrate materials belonging to $ABCO_4$ group (where A- Sr or Ca, B- rare earth element, C- Al or Ga) of different orientations and YBCO thin films.

There are many materials used as substrates for HTsC thin films. $ABCO_4$ group of compounds is characterized by small dielectric constants (it is necessary for microwave applications of HTsC films), absence of twins and small misfit [2]. Three most interesting compounds $CaNdAlO_4$, $SrLaAlO_4$ and $SrLaGaO_4$ were investigated. All these compounds are of pseudo - perovskite structure with space group $I4/mmm$. This structure is very similar to structure of YBCO. SLG substrate has the lowest misfit (0.3%) and dielectric constant.

For preparation of thin films on substrates of this group of compound plane of $\langle 100 \rangle$ orientation are mainly used. Good quality films of $\langle 001 \rangle$ orientations are obtained [3]. In this case not only a-a misfit play role, but c-3b misfit is very important too.

Sometimes, for preparation of thin films substrates of $\langle 001 \rangle$ and $\langle 110 \rangle$ orientations were used. On these substrates good films of YBCO with the same orientations were manufactured [3].

Different misfits for different YBCO faces have been analyzed. It has been found that the mismatching factor for (100) face is very similar to that for (001) face so there is possibility of preparation of thin films on both orientations.

$SrLaAlO_4$ (SLA) and $SrLaGaO_4$ (SLG) crystals of general formula $ABCO_4$ have been grown by the Czochralski method. The quality of SLA and SLG crystals strongly depends on axial gradient of temperature and growth and rotation rates.

High quality crystals were obtained at axial gradient of temperature near crystal-melt interface lower than $50^\circ\text{C}/\text{cm}$, growth rate 1-3 mm/h and the rotation rate changing from 10-20rpm [4].

Strong anisotropy in morphology of SLA and SLG single crystals grown by the Czochralski method is clearly visible. On the basis of our considerations for ABCO_4 type of the tetragonal crystals there can appear $\{001\}$, $\{101\}$ and $\{110\}$ faces for ionic type model [5]. Morphology of these crystals depend on ionic-covalent character of bonding and crystal growth parameters. Point defects are observed in crystals and they are reflected in color changes (colorless, yellow, green). Point defects are detected in directions perpendicular to oxide planes and are connected with instability of oxygen position in lattice.

To investigate facets formations crystals were doped with Cr^{3+} , Er^{3+} , Pr^{3+} , Ba^{2+} . Chromium greater size ion which is substituted for Al^{3+} clearly induces faceting. There appear easy $\{110\}$ faces and SLA crystals crack even then the amount of Cr is below 0.3at.%. SLG single crystals are not so sensitive to the content of chromium ions.

It was also found that if $\{110\}$ face appears at the beginning of growth process the crystal changes its color on the plane $\{110\}$ but it happens only on the shoulder part. The projection of $\{110\}$ face has a great amount of oxygen positions which can be easily defected. Pure and doped SLA and SLG crystals measured by EPR in the $\langle 110 \rangle$ direction show more intensive lines than in other directions which allows to suggest that the amount of oxygen defects on the $\{110\}$ plane is higher.

In order to find the origin of colors and their relation with the crystal stability, a set of SLA and SLG crystals were investigated using optical spectroscopy. The colored samples exhibit an absorption band stretching from the UV absorption edge of the crystal, from about 240 nm to about 550 nm. In the case of colorless sample, the absorption spectrum consists of a relatively weak band in the UV region. The spectral position and intensities of absorption bands of SLA are typical for imperfection similar to color centers which may be created in most of oxide crystals by UV and X-radiation.

It is pointed out that crystal growth process of polycomponent oxide crystals by Czochralski method depends on the preparation of melt and its stoichiometry, orientation of seed, gradient of temperature at crystal-melt interface, parameters of growth (rotation and pulling rate) and control of red-ox atmosphere during seeding and growth. Growth parameters have an influence on the morphology of crystal-melt interface, type and concentration of defects.

References:

1. Ruyan Guo, A.S. Bhalla, L.E. Cross and Rustum Roy, *J. Mater. Res.* 9 (1994) 1644
2. K. Mazur, J. Sass, A. Pajaczkowska, *SPIE Liquid and Solid State Crystals* 1845 (1992) 103
3. S. Hotsu, J. Ishii, T. Kawai and S. Kawai, *Appl. Phys. Lett.* 59 (1991) 2886.
4. A. Gloubokov, R. Jablonski, W. Ryba-Romanowski, J. Sass, A. Pajaczkowska, R. Uecker and P. Reiche, *J. Crystal Growth* 147(1995)123.
5. E. Janssen, A. Gloubokov, A. Pajaczkowska and C.F. Woensdregt, "Growth Morphology of Tetragonal $ABCO_4$ Compounds: Theory and Observations on Czochralski Growth Crystals", submitted to ICCGXI' 95, in preparation.

OXIDE PEROVSKITE CRYSTALS

TYPE $ABCO_4$:

APPLICATION AND GROWTH

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1. aim of work: applications as substrate for HTSC and GaN (SrLaAlO₄, SrLaGaO₄ - single crystals)
2. structure of the tetragonal ABCO₄ type compounds
3. growth by the Czochralski method
 - not flat crystal-melt interface
 - nonstoichiometric melt
 - growth atmosphere
 - rotation and pulling rates
4. experimental and theoretical morphology
5. structure imperfections:
X-ray, ESR, optical absorption, Brillouin light scattering
6. conclusions

Table 2. PEROVSKITE - TYPE SUBSTRATE MATERIALS FOR HTCS THIN FILMS

Material	SrTiO ₃	LaAlO ₃	LaGaO ₃	NdGaO ₃	Sr ₂ AlTaO ₆	SrLaAlO ₄	SrLaGaO ₄
Unit Cell	Cubic ^{16,36}	Rhombo ^{16,20,36}	Ortho ^{16,36}	Ortho ^{18,20,36}	Cubic ³³	Tetra ^{16,22}	Tetra ^{32,34}
Lattice constants, nm	a b c	0.5357 $\alpha=60^{\circ}06'$	0.5519 0.5494 0.777	0.5428 0.5498 0.711	0.3895	0.3754	0.3843
Calculated parameter a_c^*	0.3905	0.3788	0.3894	0.3863	0.3895	0.3754	0.3843
Lattice mismatch, % ^{***}	YBCO ³⁶ BSSCO ^{15,**} HBCCO ³⁵	1.0 0.7 1.5	0.7 2.2 1.2	0.07 0.6 0.4	0.74 2.0 1.3	3.0 1.6 2.5	0.6 0.7 0.08
Twins	+	+	+	±	-	-	-
Dielectric properties at Given Frequency Range, (GHz) ^{****}	10 - 300	10 - 700	10 - 500	10 - 300	10 - 100	10 - 500	10
Dielectric constant	$\epsilon'(300K)$ $\epsilon'(100K)$	20 21.5	26 25	22.8 22	11.9	17 16.7	22
Loss tangents $\tan(\delta)$	(300K) (100K)	$3 \cdot 10^{-2}$ $1 \cdot 10^{-3}$	$8 \cdot 10^{-3}$ $6 \cdot 10^{-3}$	$8 \cdot 10^{-3}$ $6 \cdot 10^{-3}$	$1.7 \cdot 10^{-3}$	$8 \cdot 10^{-4}$ $2 \cdot 10^{-4}$	$5.7 \cdot 10^{-5}$ $2 \cdot 10^{-5}$
Linear thermal coefficient expansion, $\alpha \cdot 10^{-6} \text{ } ^{\circ}\text{C}^{-1}$	9.4	11	9	10		7.55	10.05
Melting point, $^{\circ}\text{C}$	1920	2100	1750	1750	1900	1650	1520

* a_c calculated according to equation: $a_c = \sqrt{(a^2 + b^2)}/2$.

** a_{c1} calculated according to equation: $a_{c1} = a_c \cdot \sqrt{2}$.

*** Δ calculated according to equation: $\Delta = |1 - a_{fitm}/a_c| \cdot 100\%$.

**** All dielectric constants and linear thermal coefficient expansion are given along a axis.

SOME PROPERTIES OF SrLaAlO₄ AND SrLaGaO₄ SINGLE CRYSTALS

Properties	SrLaAlO ₄	SrLaGaO ₄
Structure (4I/mmm)		
a=b	0.3754 nm	0.3843 nm
c	1.263 nm	1.268 nm
Hardness		
on {001} planes	3512 MPa	7394 MPa
on {100} planes	6349 MPa	7119 MPa
Thermal conductivity (300K)		
along 'a' axis	7.078 W m ⁻¹ K ⁻¹	3.297 W m ⁻¹ K ⁻¹
along 'c' axis	1.170 W m ⁻¹ K ⁻¹	4.215 W m ⁻¹ K ⁻¹
Claveage plane	{001}	?

CONCLUSIONS:

The Hartman-Perdok theory explains the form of the crystal-melt interface of SLA and SLG crystals grown from the melt by the Czochralski method.

The experiments confirm that (001) is the most stable face of the tetragonal $ABCO_4$ structure.

The appearance of {103} on SLG crystals can be explained by assuming that the Ga-O bonding is much weaker than the Al-O bonding especially at the conditions of superheating. This aspect has also be taken into account in the models with reduced effective oxygen charges.

The conclusion is that {110} and {103} facets should be avoided at the beginning of growth as they are not appropriate for crystal growth due to their association with coloring and point defects.

It was found that the best quality crystals are grown on {101} faces.

Point defects can be removed by fitting growth conditions relate to the crystal properties as well as their morphology.

SOME PROPERTIES OF SrLaAlO₄ AND SrLaGaO₄ SINGLE CRYSTALS

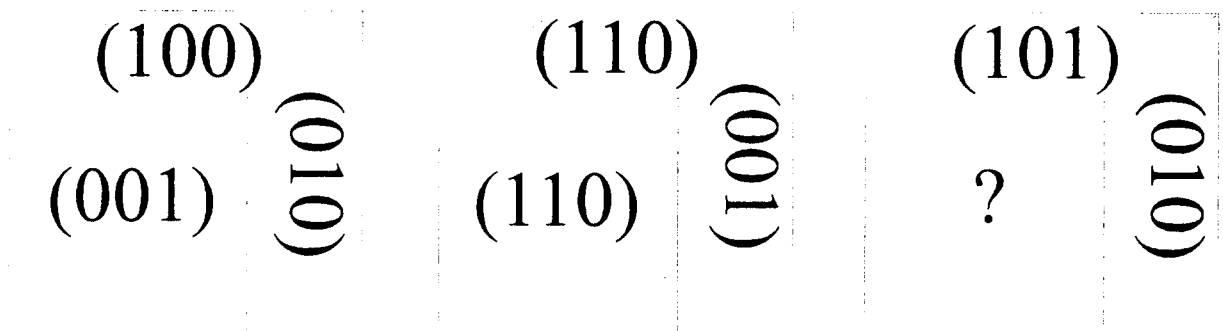
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ELASTIC PROPERTIES - BRILLOUIN LIGHT SCATTERING

SrLaAlO₄ (SLA) and SrLaGaO₄ (SLG) compounds crystallize in the perovskite-like, tetragonal K₂NiF₄ - type structure of I4/mmm space group. They have six independent elastic constants:

$$C_{11} = C_{22}, C_{33}, C_{44} = C_{55}, C_{66}, C_{12}, C_{13} = C_{23}.$$

Crystals of different geometry were measured:



The data for determination of the elastic constants, obtained from Brillouin spectra - Table 1. Using different scattering geometries the velocity of longitudinal (L) and transverse (T) modes were characterized by different polarization u. The velocity of acoustic phonons propagating along different directions in SLA and SLG single crystals was determined.

The velocity V_i of the transverse and longitudinal phonons were deduced from the measured frequency shifts $\Delta \omega_B$, using the Brillouin equation, which in the case of 90° scattering geometry takes the form:

$$\Delta \omega_B = V_i \omega_i (n_i^2 + n_s^2 - 2n_i n_s \cos \theta)^{1/2} / c$$

where ω_i is the frequency of the incident light, n_i and n_s are the refractive indices for the polarization of incident and scattered light, respectively and θ is the angle between the incident and scattered beams.

The velocities were then used to estimate the elastic constants C_{ij} . The elastic constants were determined from the solution of the equation of motion:

$$|C_{ijkl} q_j q_k - \rho V^2 \sigma_{ij}|$$

Here q_j, q_k are the direction cosines of q , ρ is the density of the crystal, C_{ijkl} are the elastic constants.

The accuracy of calculations is no more than 2%.

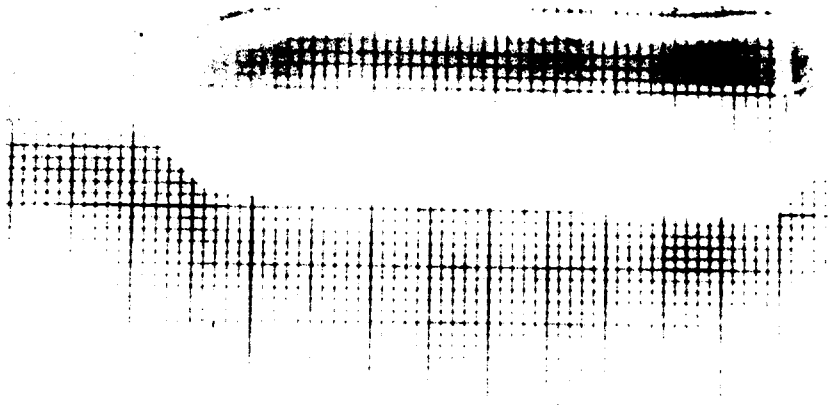
Results show that for SLG single crystals, the velocity of the longitudinal and transverse acoustic phonons propagating in (001) plane is different in a and b directions.

Lower value of the velocity in a direction can be probably caused by the damping of the elastic waves in this direction due to the existence of some kind of defects.

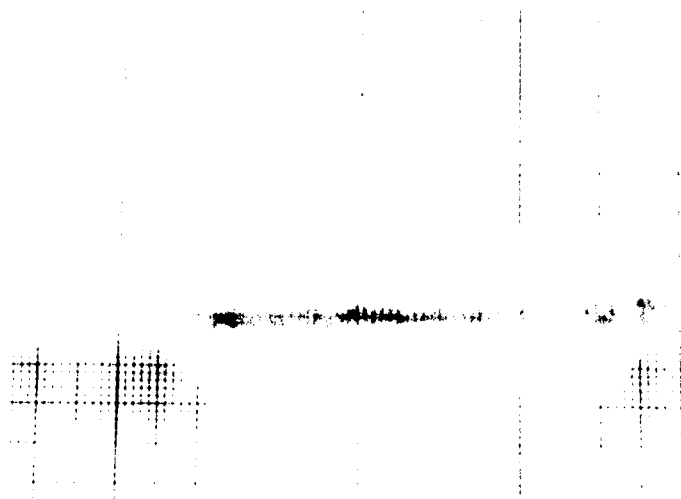
Table I. The data which served as a basis for the determination of the elastic constants C_{ij} of SrLaAlO₄ and SrLaGaO₄ single crystals.

No	q	u		ρV^2	SLA			SLG		
					$\Delta\omega_B$ [cm ⁻¹]	V [m/s]	ρV^2 *10 ¹⁰ [N/m ²]	$\Delta\omega_B$ [cm ⁻¹]	V [m/s]	ρV^2 *10 ¹⁰ [N/m ²]
1	[101]	[101]	QL	$\frac{(C_{11}+C_{33}+2C_{44})+\sqrt{(C_{11}-C_{33})^2+4(C_{13}+C_{44})^2}}{4}$	1,2879	6891	28,1	1,2590	6658	28,3
2	[101]	[101]	QT	$\frac{(C_{11}+C_{33}+2C_{44})-\sqrt{(C_{11}-C_{33})^2+4(C_{13}+C_{44})^2}}{4}$	0,6318	3381	6,8	0,5972	3159	6,4
3	[101]	[010]	T	$\frac{C_{44}+C_{66}}{2}$	0,8144	4358	11,2	0,731	3866	9,5
4*	[011]	[011]	QL	$\frac{(C_{11}+C_{33}+2C_{44})+\sqrt{(C_{11}-C_{33})^2+4(C_{13}+C_{44})^2}}{4}$	1,2803	6851	27,8	1,2349	6531	27,3
5*	[011]	[011]	QT	$\frac{(C_{11}+C_{33}+2C_{44})-\sqrt{(C_{11}-C_{33})^2+4(C_{13}+C_{44})^2}}{4}$	0,6345	3395	6,8	0,5875	3107	6,2
6*	[011]	[100]	T	$\frac{C_{44}+C_{66}}{2}$	0,8144	4358	11,2	0,7322	3873	9,6
7*	[110]	[110]	L	$\frac{C_{11}+C_{12}+2C_{66}}{2}$	1,3908	7442	32,8	1,2308	6510	27,1
8	[110]	[001]	T	C_{44}	0,7794	4171	10,3	0,7202	3809	9,3
9*	[010]	[010]	L	C_{11}	1,2673	6781	27,2	1,2507	6615	28,0
10*	[010]	[001]	T	C_{44}	0,7611	4073	9,8	0,7284	3852	9,5
11	[100]	[100]	L	C_{11}	1,2709	6801	27,4	1,2158	6430	26,4
12	[100]	[001]	T	C_{44}	0,7566	4049	9,7	0,7092	3751	9,0
13*	[100]	[010]	T	C_{66}	0,8413	4501	12,0	0,6766	3579	8,2
14*	[001]	[001]	L	C_{33}	1,2778	6838	27,7	1,2002	6348	25,7
15	[001]	[010]	T	C_{44}	0,796	4259	10,7	0,6873	3635	8,4

(14). Therefore, for the calculations of the elastic constants, for both SLA and SLG single crystals, we have chosen only scattering geometries marked by asterisk.



SrLaAlO₄



SrLaGaO₄

CONCLUSIONS:

The Hartman-Perdok theory explains the form of the crystal-melt interface of SLA and SLG crystals grown from the melt by the Czochralski method.

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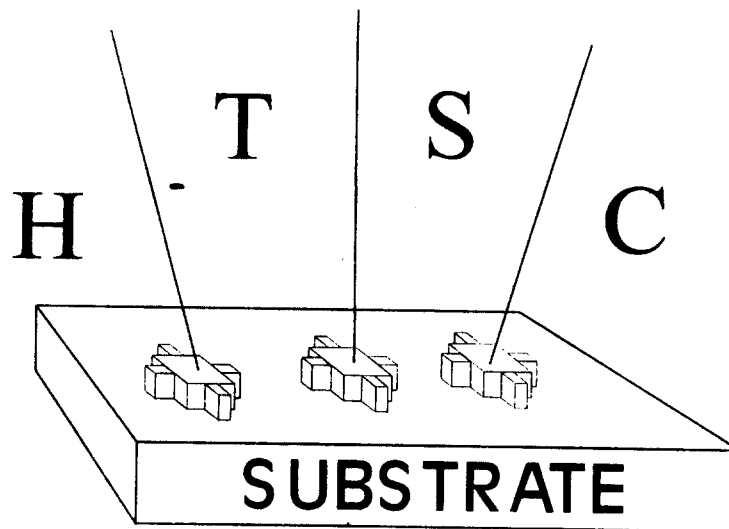
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International Conference



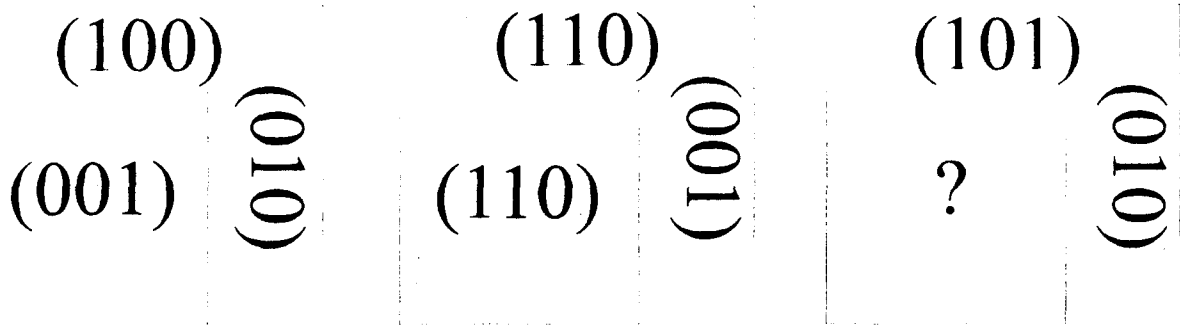
**on Substrate Crystals and HTSC
Films, ICSC-F '96,
Jaszowiec, Poland, September 16-20, 1996**

ELASTIC PROPERTIES - BRILLOUIN LIGHT SCATTERING

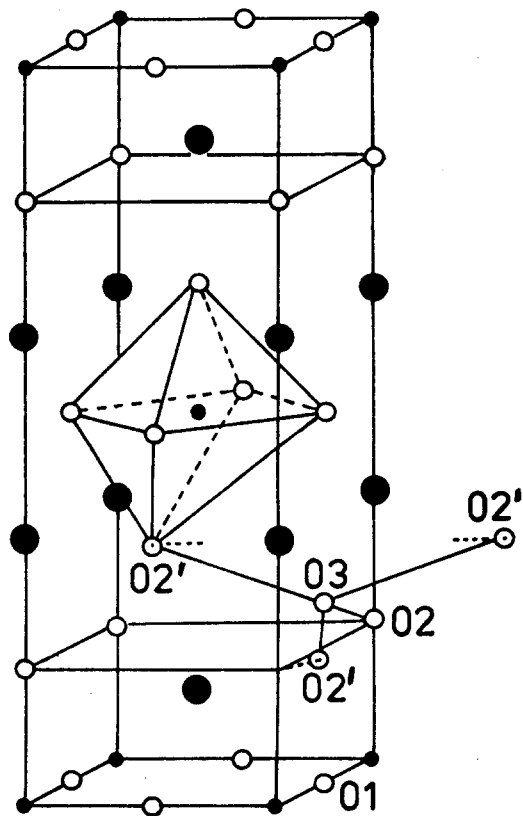
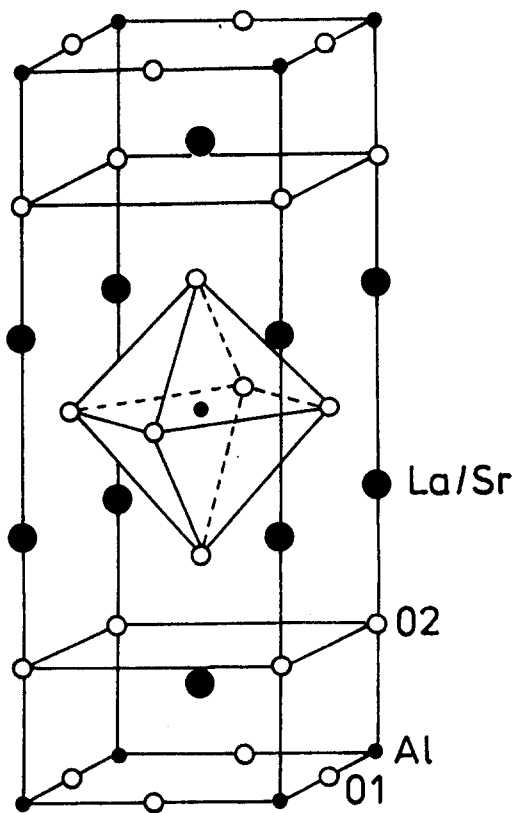
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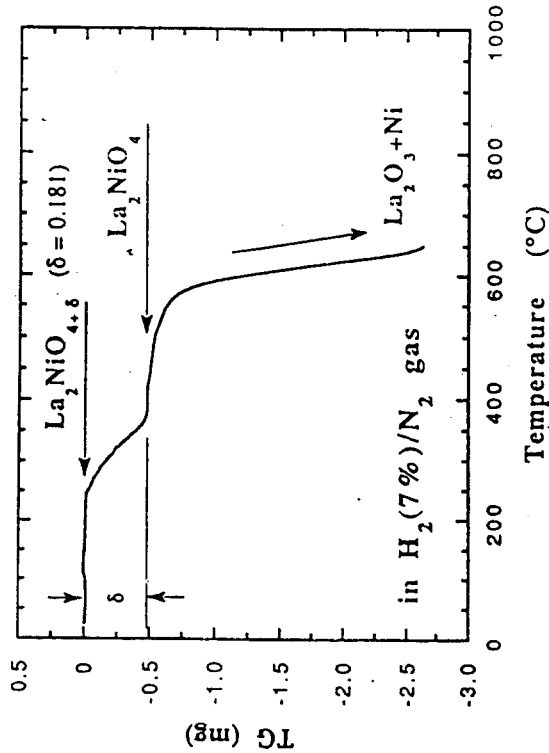
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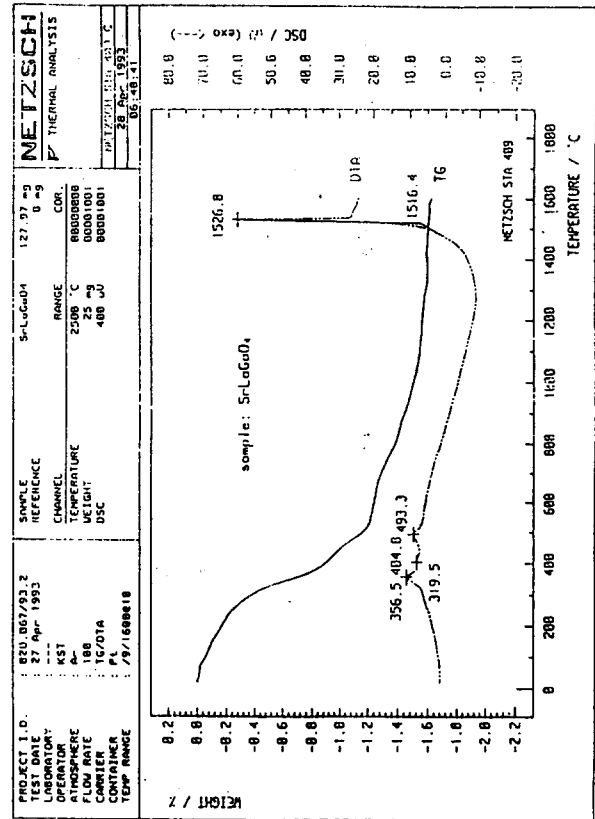
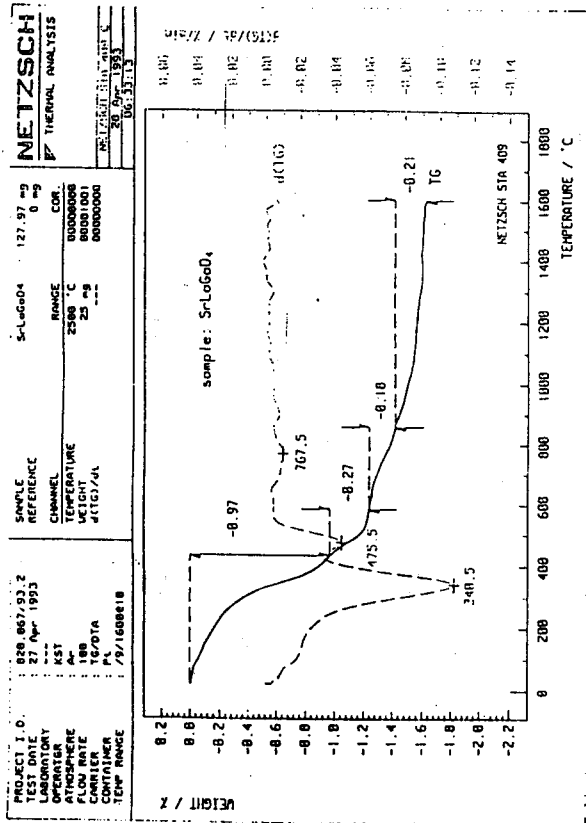
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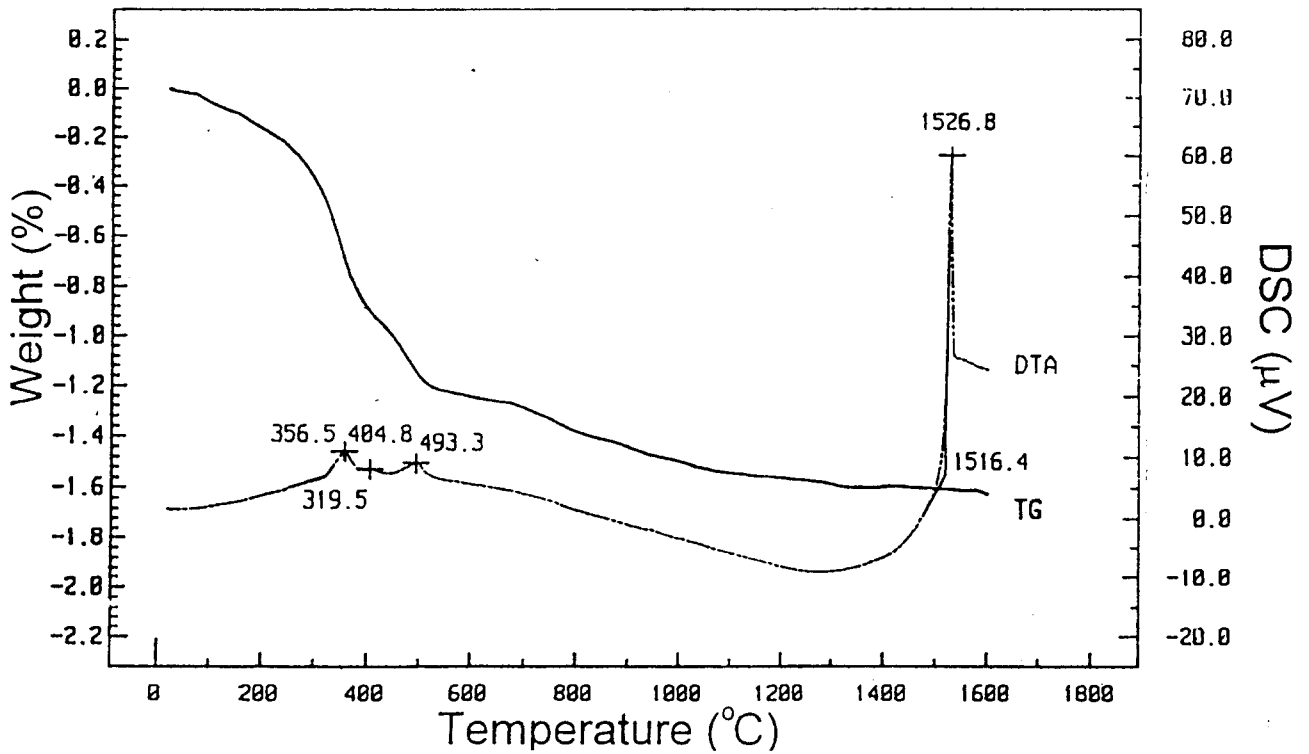
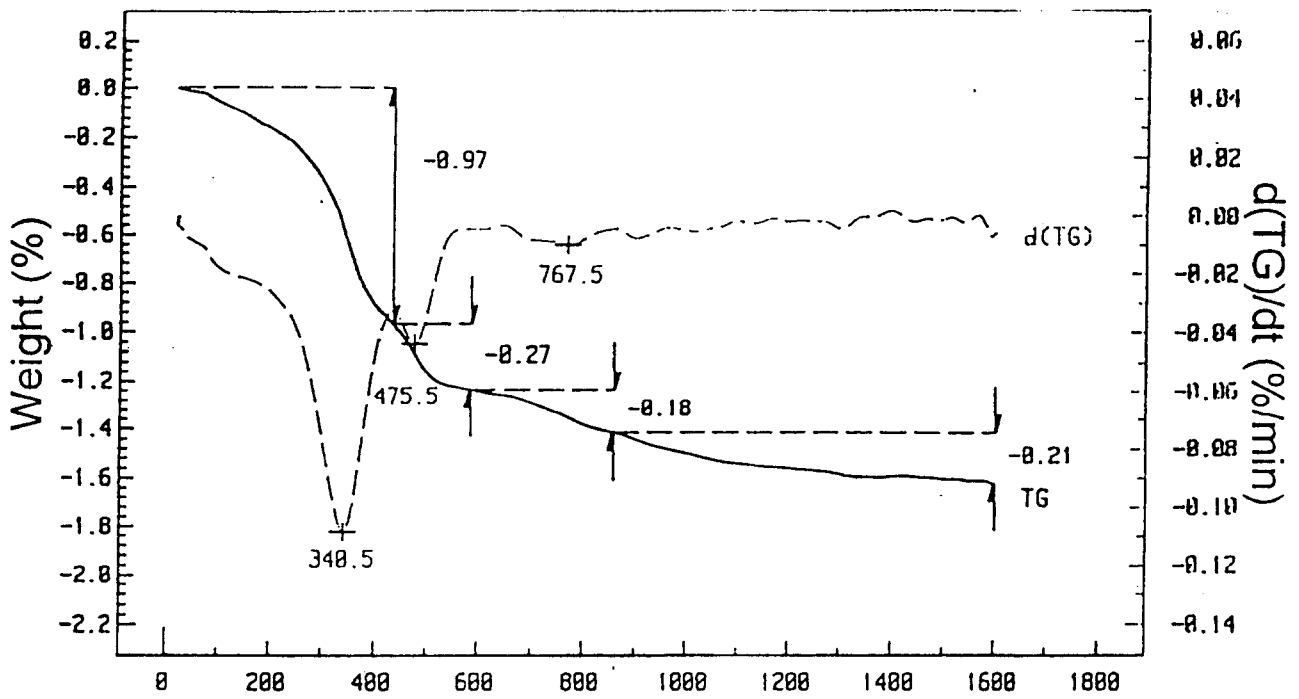
TG measurements of SLG and $\text{La}_2\text{NiO}_{4+\delta}$ compounds.



TG curve for the $\text{La}_2\text{NiO}_{4+\delta}$ crystal ($\delta = 0.18$) grown at $P(\text{O}_2) = 3$ atm. The first drop in the curve corresponds to the removal of excess oxygen δ , and the second one to the reduction of NiO to Ni.



THERMAL ANALYSIS OF SLG - synthesized



Auger electron spectroscopy (AES)

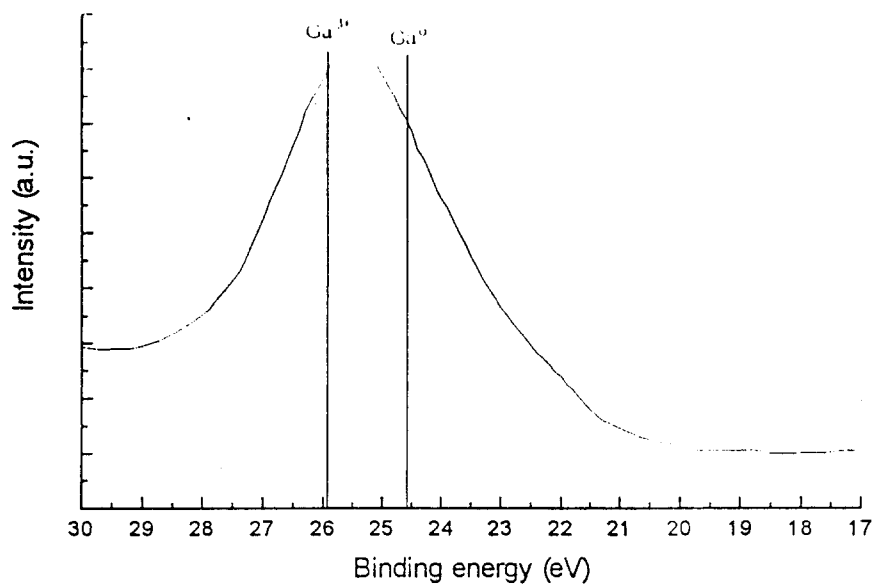
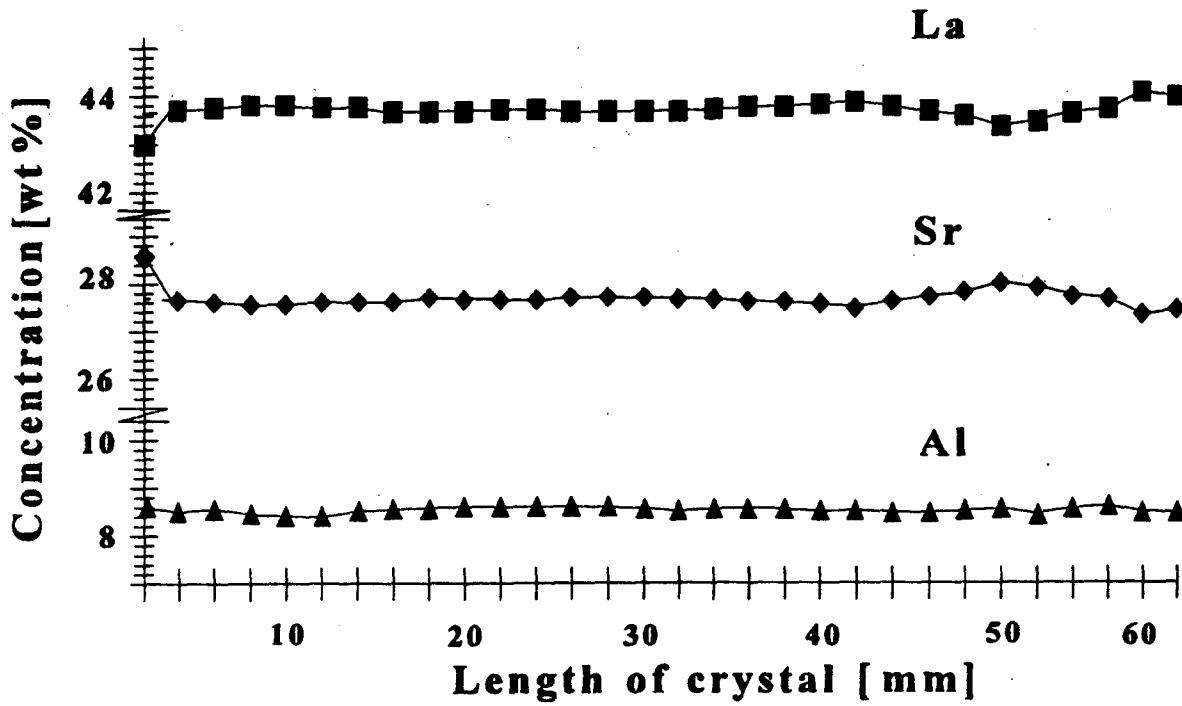
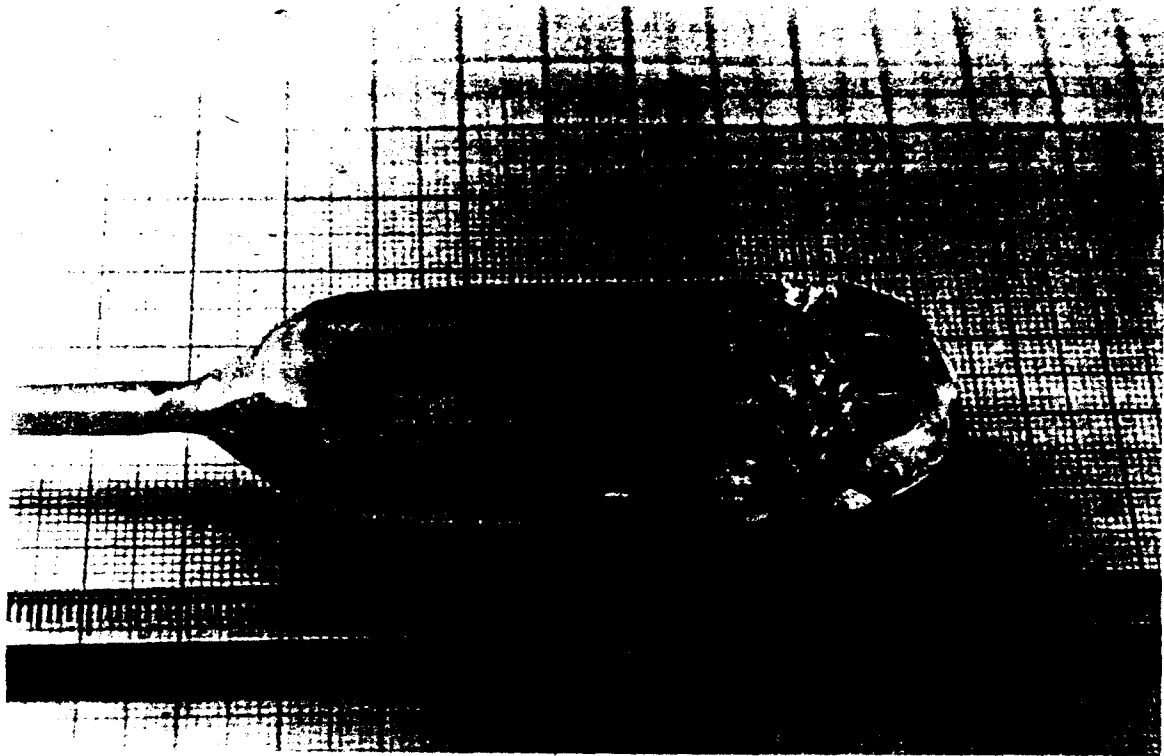
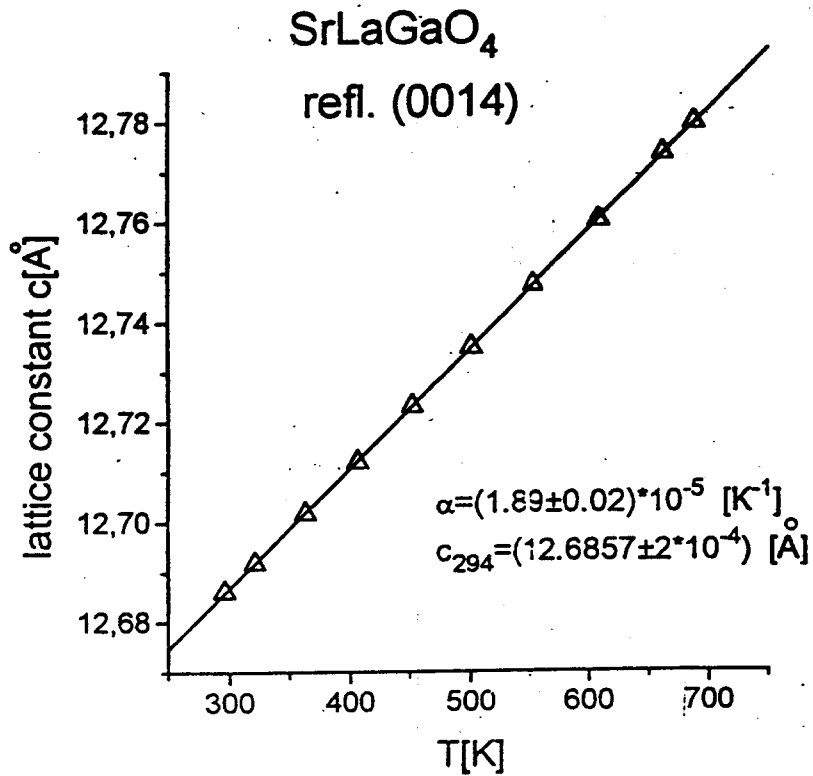
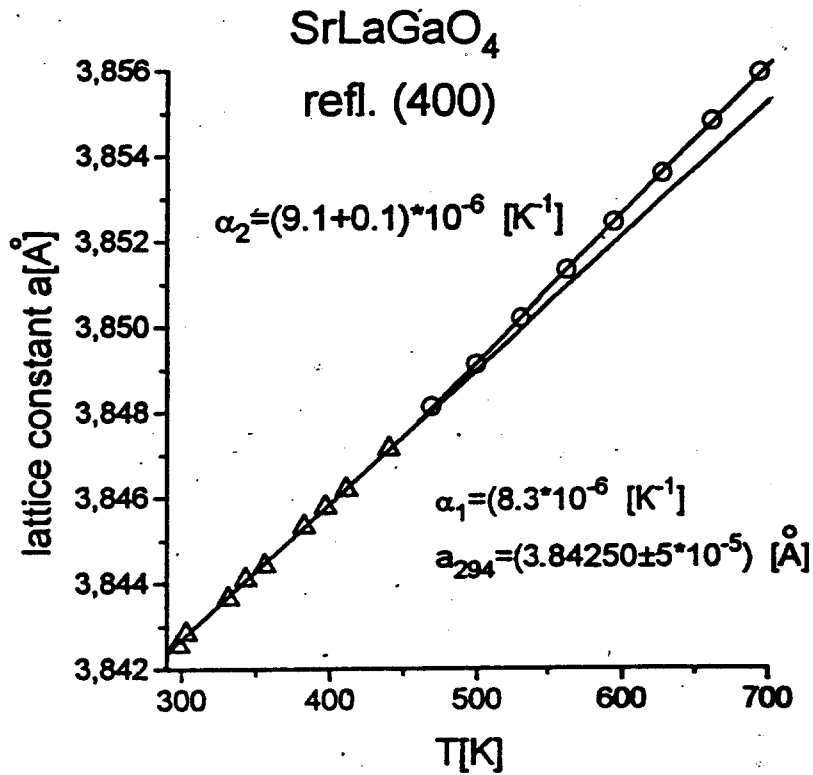


Figure 35. AES spectra of Ga ion (3d line, vacuum 10^{-9} mbar).

EPMA measurements

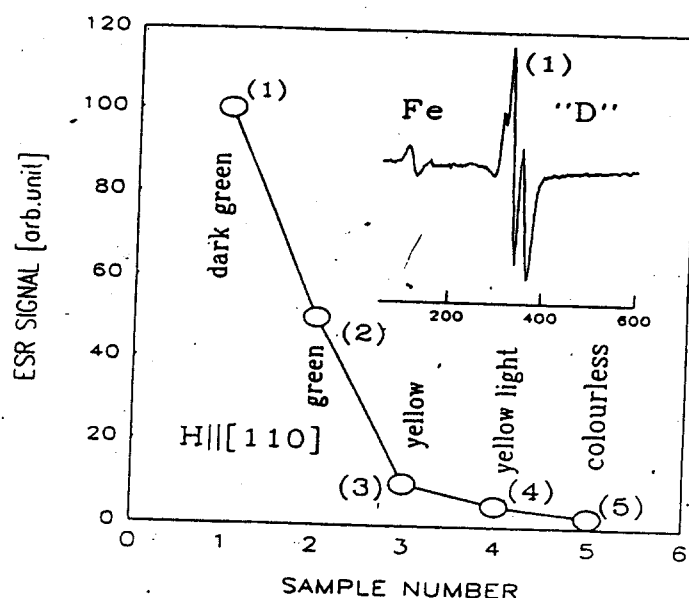


EPMA measurements of La, Sr and Al distribution along SrLaAlO_4 crystal

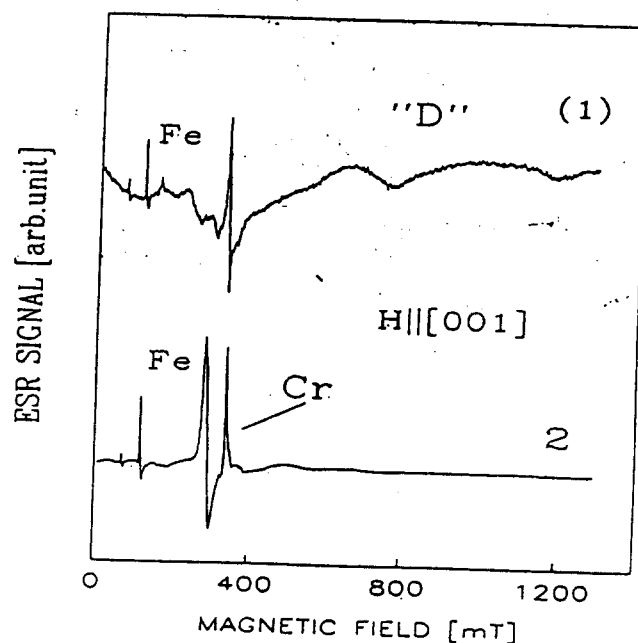


Temperature dependence of a and c lattice constants in SrLaGaO₄. The lattice constants at room temperature and thermal expansion coefficients are given.

4. ESR measurements



ESR intensity signals for various colored crystals related to the intensity of "D" line shown in the spectrum of the inset, presented for the dark green colored crystal (1). Signal of left side belongs to Fe impurity less 10^{-3} weight %. Spectra are given at 20 K and frequency $\nu = 9.423$ GHz, $P = 2$ mW.



ESR intensity signals for $H \parallel [001]$ of the dark green crystal (1), above Fig. and crystal doped Fe and Cr ($1.5 \cdot 10^{-2}$ weight), curve 2. Spectra are given at 20 K and frequency $\nu = 9.423$ GHz, $P = 2$ mW.

A B S O R P T I O N S P E C T R A

SLA - single crystals - SLG

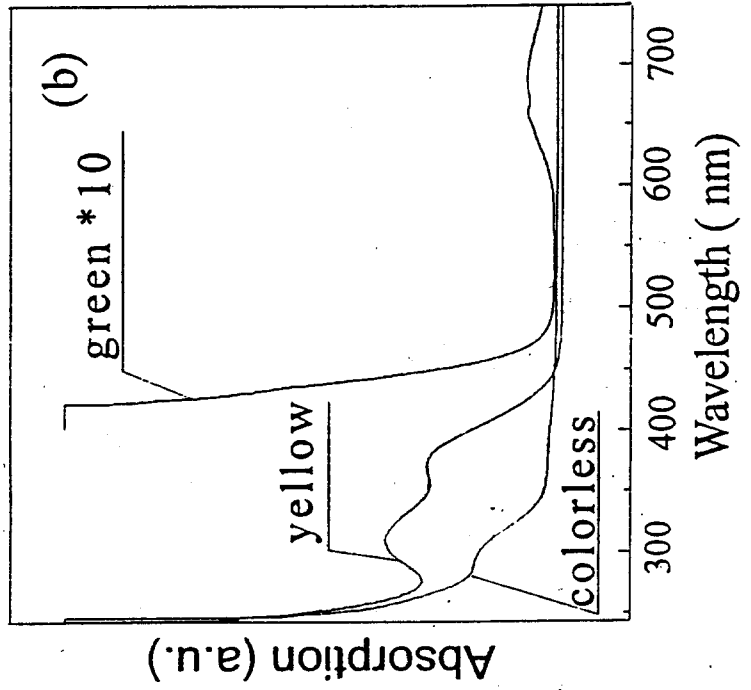
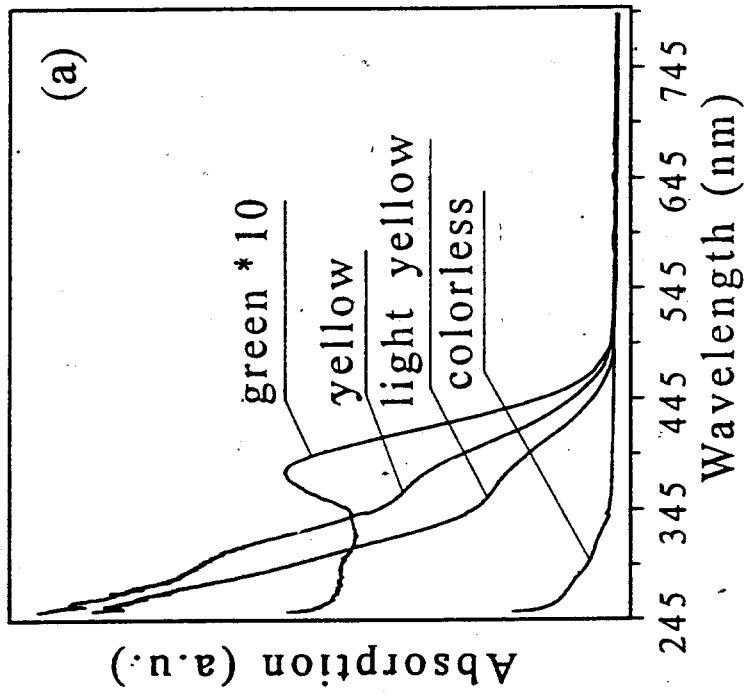
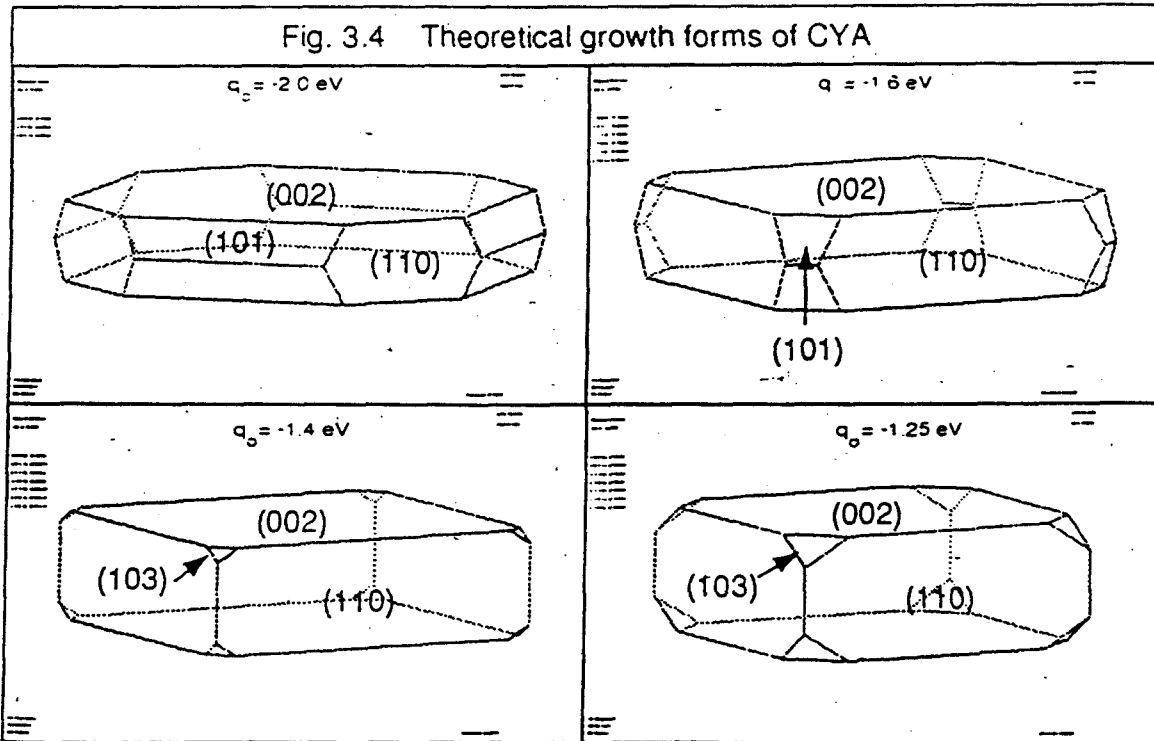
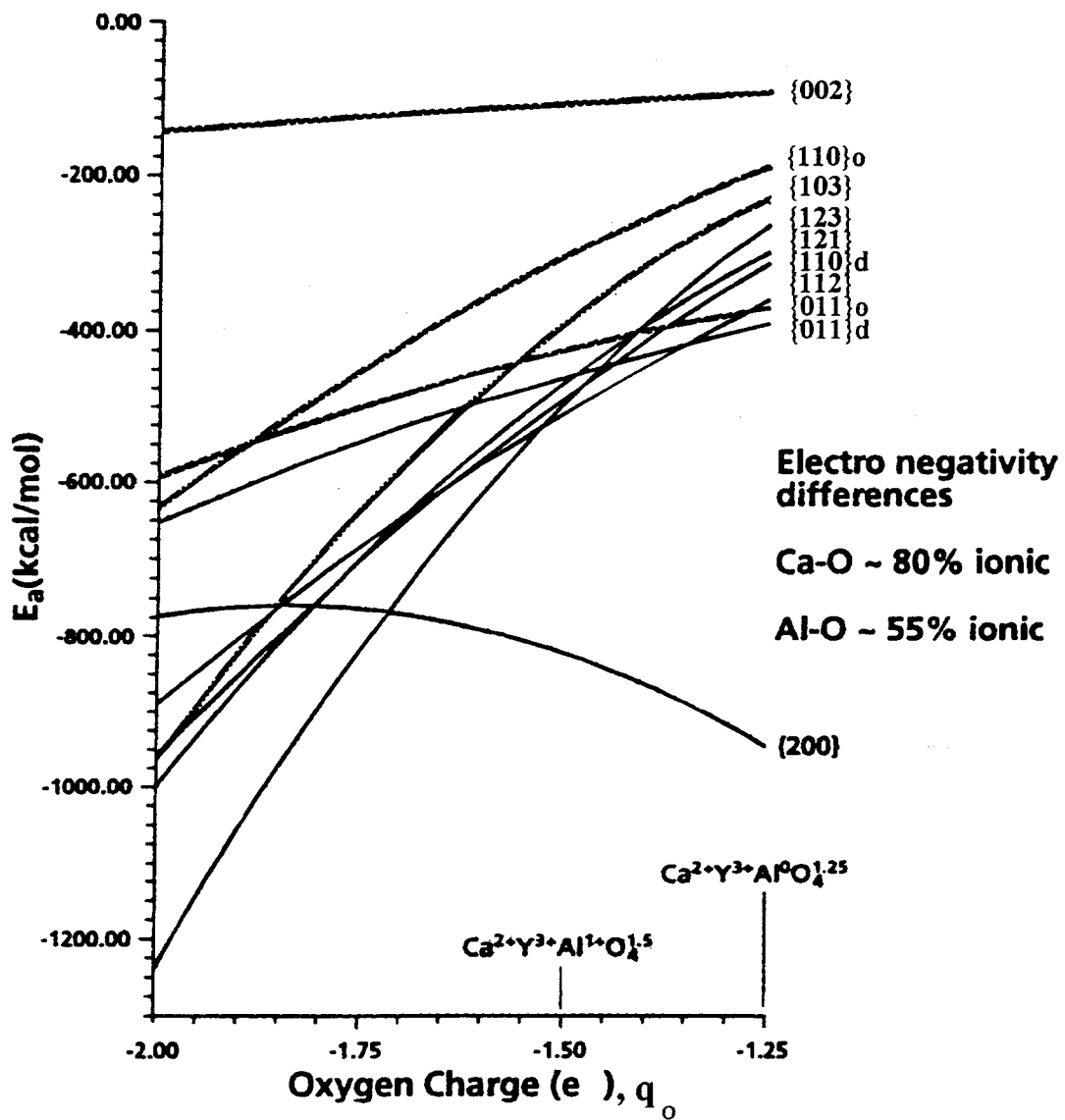


Fig. 3.4 Theoretical growth forms of CYA



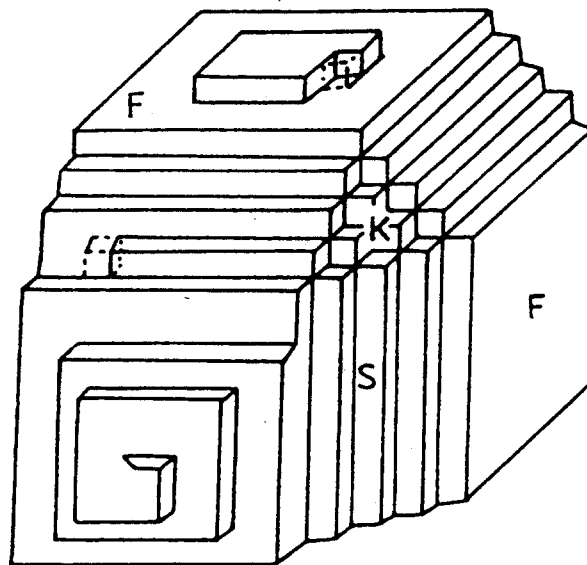


Hartman classifies the faces of a crystal into **F** (flat), **S** (stepped) and **K** (kinked) faces.

F - type faces possess at least two sets of chains of periodically bonded atoms, molecules or radicals (called Periodic Bond Chains, PBCs) **S** faces have one such PBC while **K** faces do not have any PBC.

Thus singular faces with minimum surface free energy are **F** faces, while **S** and **K** faces correspond to vicinal and nonsingular faces, respectively.

F - CaYAlO_4 , $q_o = -2e$, in order of decreasing d_{hkl} :
{002}, {101}, {103}, {110}, {112}, {200}, {123}



Classification of different types of faces of a simple cubic crystal according to the Periodic Bond Chains (PBC):

F (flat), **S** (stepped) and **K** (kinked).

SrLaAlO₄ (SLA) and SrLaGaO₄ (SLG) crystals of different colors, cracked and opaque have been found:

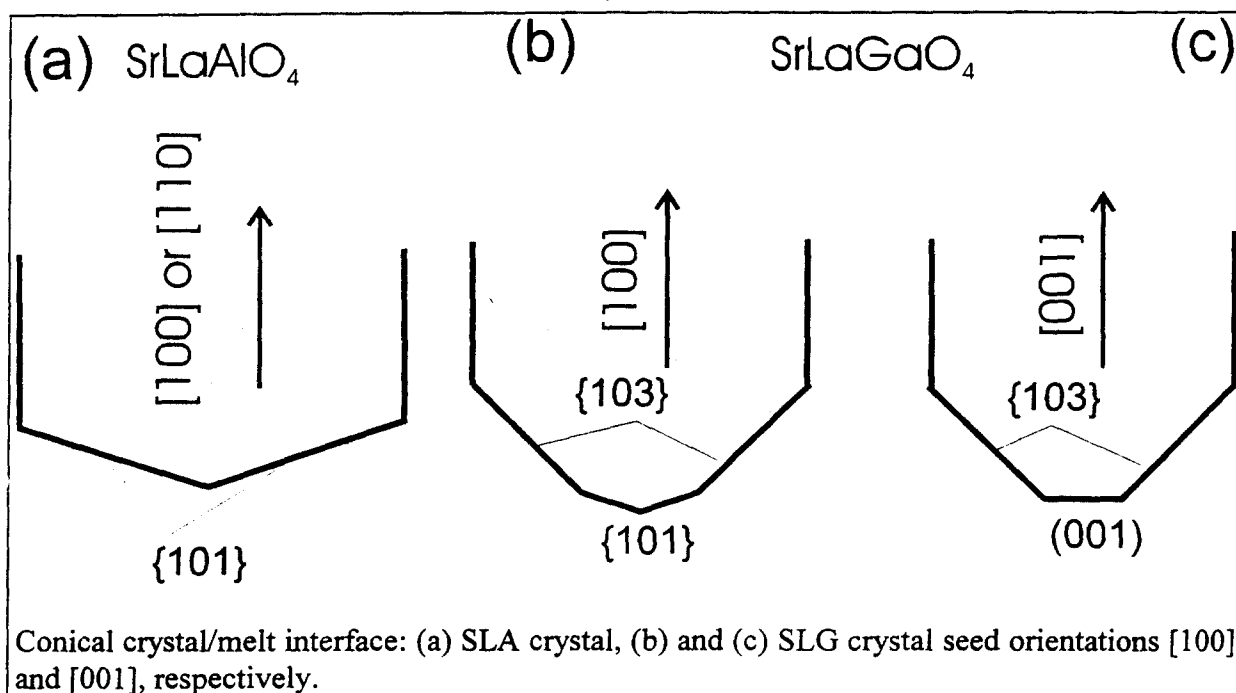
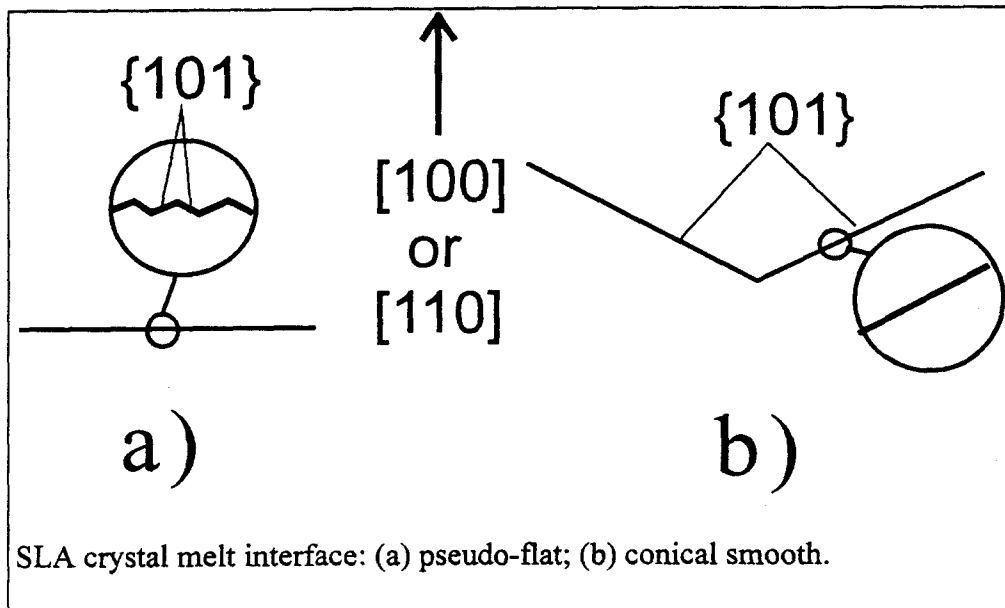
- good quality crystals (not cracked from top to bottom) are colorless-yellow,
- green color appears at the top of crystal if temperature gradient at the melt surface is high (higher than about 100 °C/cm), and oxygen content in nitrogen about 1 %vol.
- yellow/brown-amber color appears near opaque, cracking part, superheated parts

Investigations of various crystals by X-ray diffraction, ESR, optical measurements and chemicals by chemical analysis and DTA/TG have been performed:

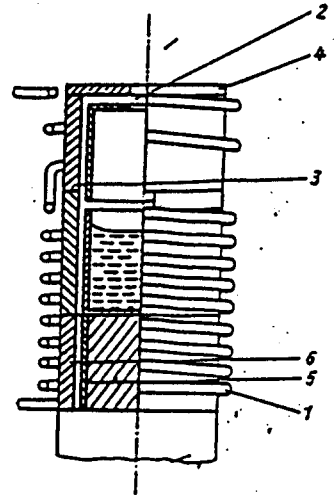
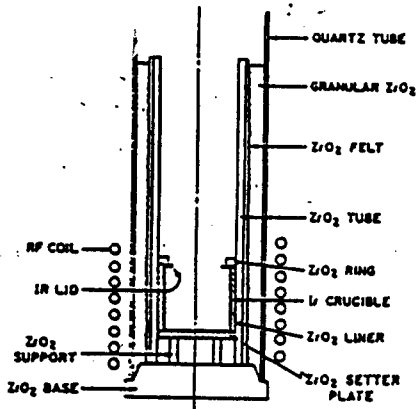
- La₂O₃ chemical is sensitive to atmosphere of storage and reactive at temperature higher than 900 °C,
- in all crystals traces of Fe ions, less than 10⁻³ weight% has been identified by ESR,
- higher contents of Fe and Cr ions have been only found in the doped samples by optical measurements as well as ESR and chemical analysis,
- the defective structure 'D' found by ESR and optical measurements, the intensity of effect was lowered from green to yellow and colorless crystals,
- these defects are related to oxygen points defects, and some of these correspond to color center (the density of defects increases in UV light irradiation)
- fluctuation of Sr-La atoms appears at the top of crystal (near the seed and at the beginning of cracking). It can be explained as result of increasing of oxygen defects accompanied by the change of Sr²⁺ and La³⁺ ions ratio,
- any other phases e.g. La₂O₃, LaO(OH) compounds and transition elements have not been detected.

Crystals are colored depending on temperature gradient at the crystal-melt interface, melt composition and oxygen partial pressure. There is controversial discussion about the origin of color which is also related to the appearance of facets and may be caused by ordering of Sr/La and oxygen ions in the structure.

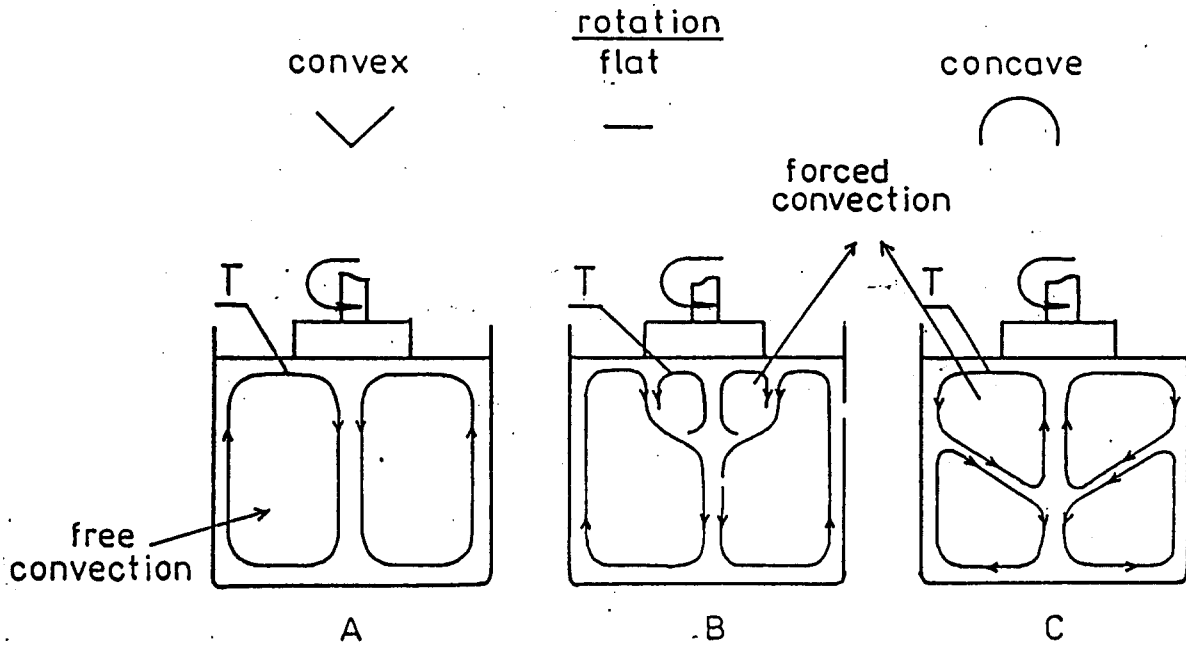
Growth morphology of SLA and SLG is strongly differed.



A Modified Heater System for RF-Czochralski Equipments



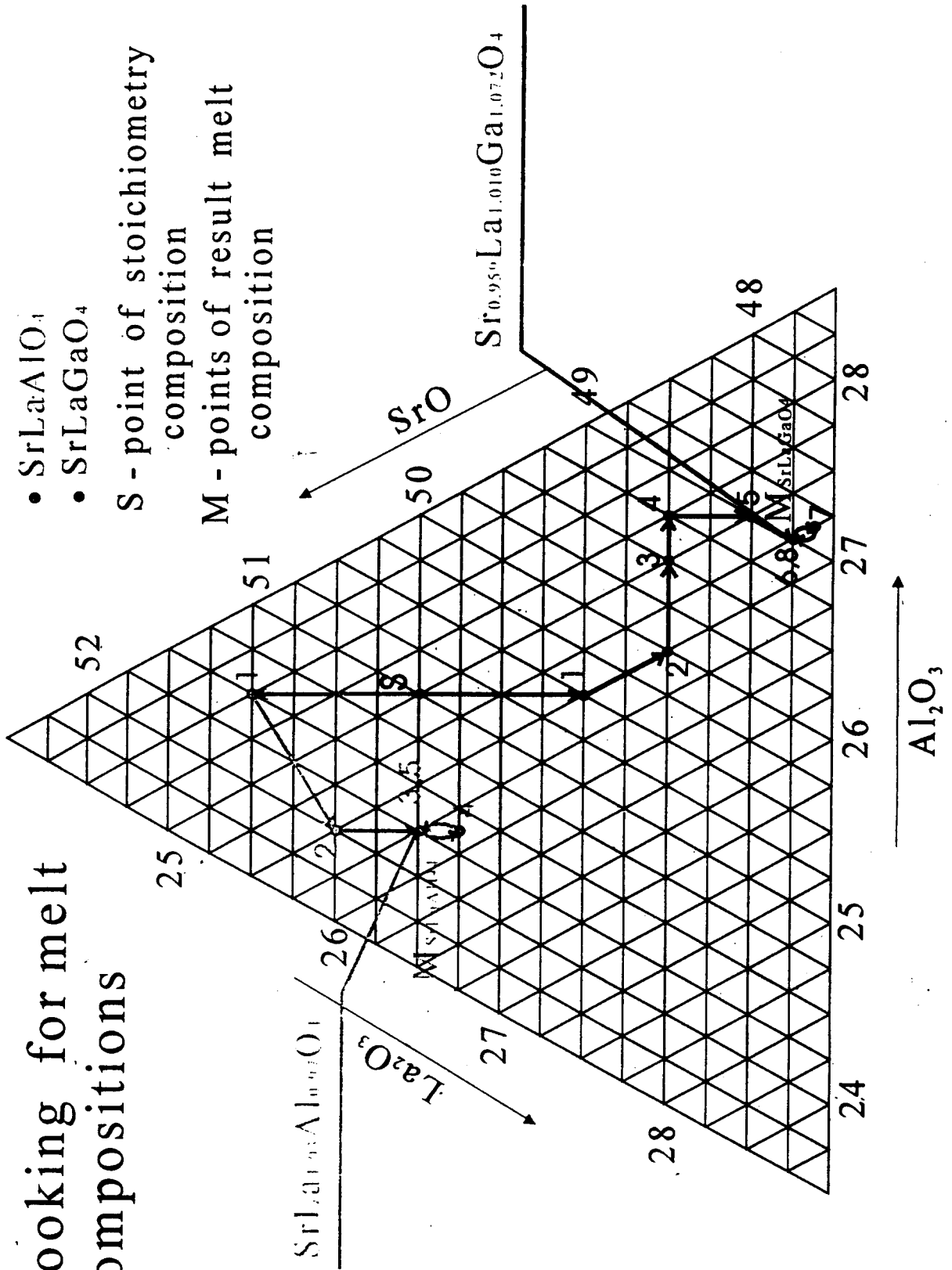
P. Reiche et al.
 Cryst. Res. Technol. 20(1985)845



Looking for melt compositions

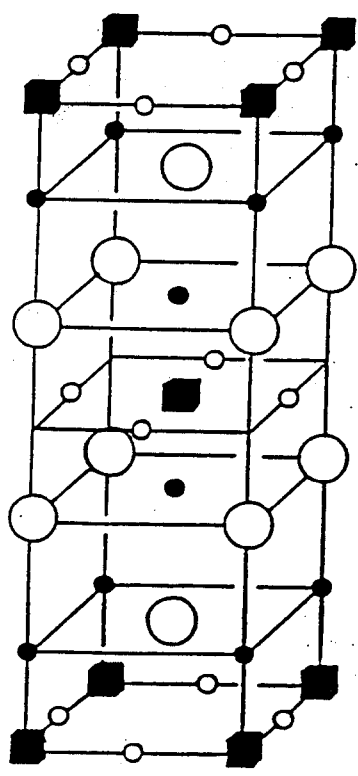
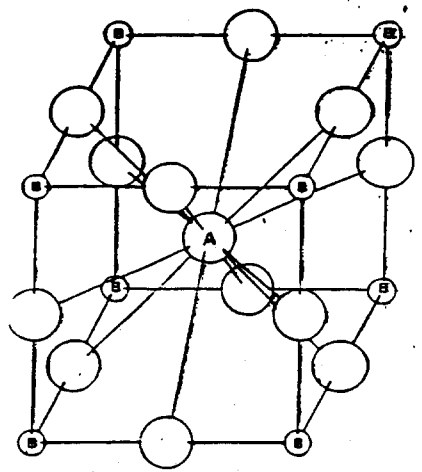
- SrLaAlO_4
- SrLaGaO_4

S - point of stoichiometry
 M - points of result melt composition



$Pm\bar{3}m$
 $(LaTiO_3, LaAlO_3)$ $\alpha = \beta = \gamma = 90^\circ; a = b = c$

$R\bar{3}m$ $a = b = c, \alpha = 90^\circ$

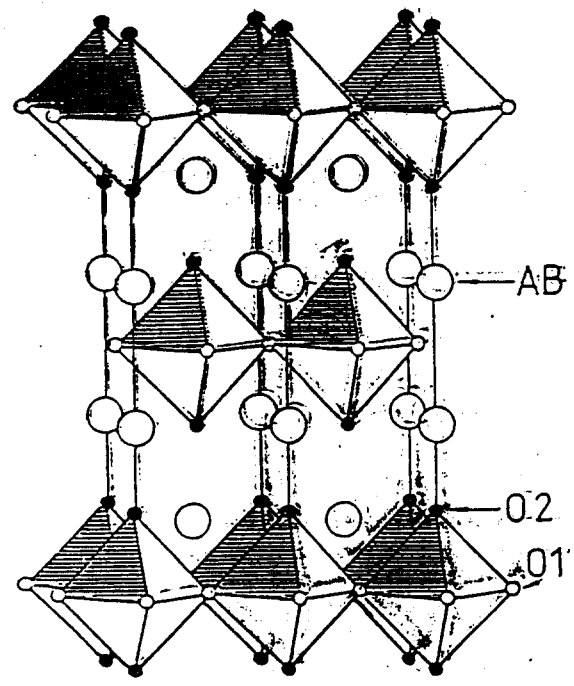


$ABCO_4$

$I4/mmm$ K_2NiF_4
 $c = 3a$

■ Al, Ga
 ● O
 ○ AB Sr^{2+} / La^{3+}

$A_2B_2C_2O_8$



AL-01 - unit cell dim.
 $\frac{1}{2}, 0, \frac{1}{2}$

AL-02 - c - cell param.
 variable z - positional param (0,0,z)
 - depend on av. ionic rad. - A-B

